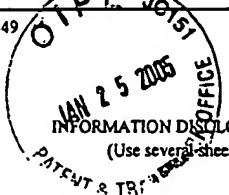


FORM PTO-1449 (REV.7-80)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. 890050.434	APPLICATION NO. 10/612,615
		APPLICANTS Hiroyasu Inoue et al.	
		FILING DATE July 1, 2003	GROUP ART UNIT 2655 2652

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
Chen	AA	3,959,799	05/25/76	Gambino et al.	346	135	
	AB	4,357,616	11/02/82	Terao et al.	346	135.1	
	AC	4,477,819	10/16/84	Lee et al.	346	76 L	
	AD	4,587,533	05/06/86	Nakane et al.	346	135.1	
	AE	4,647,947	03/03/87	Takeoka	346	135.1	
	AF	4,670,345	06/02/87	Morimoto	428	411.1	
	AG	4,771,413	09/13/88	Nago	369	109	
	AH	4,772,897	09/20/88	Ohkawa	346	135.1	
	AI	5,208,088	05/04/93	Tominaga et al.	428	64	
Chen	AJ	5,297,132	03/22/94	Takano et al.	369	284	

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
Chen	AK	57-022095	02/04/82	JP (Abstract in English only)		
	AL	57-027788	02/15/82	JP (+ Abstract in English)		
	AM	58-220794	12/22/83	JP (+ Abstract in English)		
	AN	59-225992	12/19/84	JP (+ Abstract in English)		
	AO	60-160036	08/21/85	JP (+ Abstract in English)		
Chen	AP	0 068 801 B1	09/10/86	EP		

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

Chen	AQ	Inoue, H., et al., "Inorganic Write-Once Disc for High Speed Recording," Jpn. J. Appl. Phys. Vol. 42, part 1, no. 2B, pp. 1056-1061, February 2003.
Chen	AR	Yoshii, K., et al., "Investigation of Hole Formation on Cr/Al, Si/Al, and C/Al Bilayer Films by Laser Beam Irradiation," <i>Journal of Applied Physics</i> 55(1):223-229, January 1, 1984.

EXAMINER

Chen Fengye

DATE CONSIDERED

06/21/05

* EXAMINER: Initial if reference considered, whether or not criteria is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant(s).

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FORM PTO-1449 (REV.7-80)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. 890050.434	APPLICATION NO. 10/612,615
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)		APPLICANTS Hiroyasu Inoue et al.	
		FILING DATE July 1, 2003	GROUP ART UNIT 2655 2652

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
Chen	BA	5,656,370	08/12/97	Murakami et al.	428	332	
	BB	5,912,104	06/15/99	Hirotsune et al.	430	270.13	
	BC	6,033,752	03/07/00	Suzuki et al.	428	64.1	
	BD	6,096,399	08/01/00	Yoshinari et al.	428	64.1	
	BE	6,143,469	11/07/00	Ohta et al.	430	270.13	
	BF	6,210,860	04/03/01	Fukano et al.	430	270.12	
	BG	6,254,966	07/03/01	Kondo	428	156	
	BH	6,551,679	04/22/03	Kuroda et al.	428	64.1	
	BI	6,608,799	08/19/03	Hozumi	369	13.26	
Chen	BJ	2001/0012257	08/09/01	Suzuki et al.	369	94	

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
Chen	BK	62-204442	09/09/87	JP (+ Abstract in English)		
	BL	62-245545	10/26/87	JP (+ Abstract in English)		
	BM	01-158633	06/21/89	JP (+ Abstract in English)		
	BN	2-152029	06/12/90	JP (+ Abstract in English)		
	BO	0 474 311 A1	03/11/92	EP		
	BP	4-86283	03/18/92	JP (+ Abstract in English)		
	BQ	4-226785	08/17/92	JP (+ Abstract in English)		
Chen	BR	6-171236	06/21/94	JP (+ Abstract in English)		

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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FORM PTO-1449 (REV.7-80)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. 890050.434	APPLICATION NO. 10/612,615
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U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
Ch	CA	2001/0021160	09/13/01	Shuy et al.	369	100	
	CB	2001/0044002	11/22/01	Shingai et al.	428	64.4	
	CC	2002/0076646	06/20/02	Zhou et al.	430	270.13	
	CD	2003/0190551	10/09/03	Aoshima et al.	430	270.12	
	CE	2003/0202452	10/30/03	Mishima et al.	369	112.23	
	CF	2004/0052194	03/18/04	Inoue et al.	369	112.23	
Ch	CG	2004/0157158	08/12/04	Kakiuchi et al.	430	270.12	

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
Ch	CH	0 350 078 B1	03/09/94	EP		
	CI	0 822 543 A1	02/04/98	EP		
	CJ	10-76755	03/24/98	JP (+ Abstract in English)		
	CK	0 978 831 A2	02/09/00	EP		
	CL	2000-187884	07/04/00	JP (+ Abstract in English)		
	CM	1 028 421 A2	08/16/00	EP		
	CN	1 154 413 A2	11/14/01	EP		
	CO	WO 01/93256 A1	12/06/01	WIPO		
	CP	1330368 A	01/09/02	CN		
	CQ	2002-104317	04/10/02	JP (+ Abstract in English)		
Ch	CR	2002-120458	04/23/02	JP (+ Abstract in English)		

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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EXAMINER

DATE CONSIDERED

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FORM PTO-1449 (REV.7-80)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. 890050.434	APPLICATION NO. 10/612,615
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)		APPLICANTS Hiroyasu Inoue et al.	
		FILING DATE July 1, 2003	GROUP ART UNIT 2655 2652

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	DA						
	DB						
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FOREIGN PATENT DOCUMENTS

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					YES	NO
Chen	DK	2002-269808	09/20/02	JP (+ Abstract in English)		
	DL	0 947 351 B1	09/25/02	EP		
	DM	2003-54135	02/26/03	JP (+ Abstract in English)		
	DN	2003-85778	03/20/03	JP (+ Abstract in English)		
Chen	DO	1 351 230 A2	10/08/03	EP		
	DP					

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

	DQ	
	DR	
	DS	

EXAMINER <i>Chen Tanya</i>	DATE CONSIDERED 06/21/05
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FORM PTO-1449
(REV. 7-80)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
890050.434APPLICATION NO.
10/612,615INFORMATION DISCLOSURE STATEMENT
(Use several sheets if necessary)

APPLICANTS

Hiroyasu Inoue et al.

FILING DATE

July 1, 2003

GROUP ART UNIT

2655 2652

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
Ch	AA	6,111,851	08/29/00	Ohki et al.	369	286	
	AB						
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
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	AN					
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	AQ	
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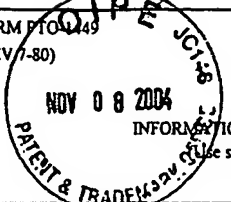
EXAMINER

Chen Tzeng

DATE CONSIDERED

06/21/05

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FORM PTO 449 (REV. 7-80)  INFORMATION DISCLOSURE STATEMENT (Include several sheets if necessary)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. 890050.434	APPLICATION NO. 10/612,615
	APPLICANTS Hiroyasu Inoue et al.			
	FILING DATE July 1, 2003		GROUP ART UNIT 2655 2652	

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
Chen	AA	5,401,330	03/28/95	Saito et al.	136	259	
Chen	AB	5,458,941	10/17/95	Hintz	428	64.4	
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
Chen	AK	1 139 340 A2	10/04/01	EP		
I	AL	1 172 811 A2	01/16/02	EP		
Chen	AM	1 178 472 A2	02/06/02	EP		
	AN					
	AO					

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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EXAMINER <i>Chen Jang</i>	DATE CONSIDERED <i>06/11/04</i>
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